## Notice of References Cited

Application/Control No.

O9/750,858

Applicant(s)/Patent Under Reexamination GEIGEL ET AL.

Examiner

Nhon (Gary) D Nguyen

Applicant(s)/Patent Under Reexamination GEIGEL ET AL.

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## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6202061 B1	03-2001	Khosla, Aditya et al.	707/3
	В	US-6014458 A	01-2000	Wang, Shin-Ywan	382/176
	С	US-5685002 A	11-1997	Sano, Homare	715/517
	D	US-6222947 B1	04-2001	Koba, Toshinori	382/284
	E	US-6571054 B1	05-2003	Tonomura, Yoshinobu et al.	386/95
	F	US-6324545 B1	11-2001	Morag, Guy	707/202
	G	US-			
	π	US-			
	-	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ω					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.